Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10792073	CHENG, HUI
Examiner	**Art Unit**
Radkiewicz, Jared W	2624

ORIGINAL	
CLASS	SUBCLASS
382	294

CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
348	584				

INTERNATIONAL CLASSIFICATION					
CLAIMED					NON-CLAIMED
G	0	6	K	9 / 32 (2006.01.01)	

/Jared Radkiewicz/ (Assistant Examiner)	11/16/2007 (Date)	11/18/07 BRIAN WERNER SUPERVISORY PATENT EXAMINER	**Total Claims Allowed:** 23
(Legal Instruments Examiner)	(Date)	(Primary Examiner) (Date)	O.G. Print Claim(s) 1 / O.G. Print Figure 1